

**WSP4409A** 

P-Ch MOSFET

#### **General Description**

The WSP4409A is the highest performance trench P-Ch MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The WSP4409A meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

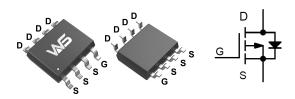
## **Product Summery**

BVDSS	RDSON	ID
-30V	8.0mΩ	-15A

#### Applications

• Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems. HBM ESD protection level pass 8KV.

## **SOP-8 Pin Configuration**



## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage	-30	V	
V <sub>GS</sub>	Gate-Source Voltage	±20	V	
I <sub>D</sub> @T₀=25℃	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-15	А	
I <sub>D</sub> @T <sub>c</sub> =70℃	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-10	А	
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	-70	А	
EAS	Single Pulse Avalanche Energy <sup>3</sup>	70	mJ	
I <sub>AS</sub>	Avalanche Current	-38	А	
P <sub>D</sub> @T <sub>A</sub> =25℃	Total Power Dissipation <sup>4</sup>	2.5	W	
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range -55 to 150		°C	

## **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-Ambient <sup>1</sup>		62.5	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		24	°C/W



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### Electrical Characteristics (T<sub>J</sub>=25<sup>-1</sup>C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-30			V
$\triangle BV_{DSS} / \triangle T_J$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25 $^\circ\!\!{\rm C}$ , $I_D\text{=-1mA}$		-0.018		V/℃
Б	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V , I <sub>D</sub> =-15A		8	10	mΩ
R <sub>DS(ON)</sub>		V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-10A		10	14	
V <sub>GS(th)</sub>	Gate Threshold Voltage		-1.0	-	-2.7	V
$ riangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS} - V_{DS}$ ; $I_D = -2500A$		5.04		mV/℃
	Drain Source Lookage Current	$V_{\text{DS}}\text{=-24V}$ , $V_{\text{GS}}\text{=}0\text{V}$ , $T_{\text{J}}\text{=}25^\circ\!\mathrm{C}$			-1	uA
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{\text{DS}}\text{=-24V}$ , $V_{\text{GS}}\text{=}0\text{V}$ , $T_{\text{J}}\text{=}55^\circ\!\mathrm{C}$	=0V , T」=55℃	-5	uA	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm20V$ , $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-10A		15		S
Qg	Total Gate Charge (-4.5V)			72		
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> =-15V,V <sub>GS</sub> =-4.5V,I <sub>D</sub> =-15A		12		nC
Q <sub>gd</sub>	Gate-Drain Charge			16		
T <sub>d(on)</sub>	Turn-On Delay Time			16		
Tr	Rise Time	$V_{DD}$ =-15V, $V_{GS}$ =-10V, $R_{G}$ =6 $\Omega$ ,		21		20
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =-1A ,RL=15Ω		80		ns
T <sub>f</sub>	Fall Time			14		
C <sub>iss</sub>	Input Capacitance			3500		
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		635		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			645		

## **Guaranteed Avalanche Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy <sup>5</sup>	V <sub>DD</sub> =-25V , L=0.5mH , I <sub>AS</sub> =-38A	30			mJ

### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I <sub>S</sub>	Continuous Source Current <sup>1,6</sup>	$V_G = V_D = 0V$ , Force Current			-4.0	А
I <sub>SM</sub>	Pulsed Source Current <sup>2,6</sup>				-70	А
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , TJ=25℃			-1.3	V
t <sub>rr</sub>	Reverse Recovery Time	IF=-17.6A,dI/dt=100A/µs,Tյ=25℃		26		nS
Qrr	Reverse Recovery Charge			18		nC

Note :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, t<10sec.

2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%

3. The EAS data shows Max. rating . The test condition is VDD=-25V, VGS=-10V, L=0.5mH, IAS=-38A

4.The power dissipation is limited by 150  $^\circ\! {\rm C}$   $\,$  junction temperature

5. The Min. value is 100% EAS tested guarantee.

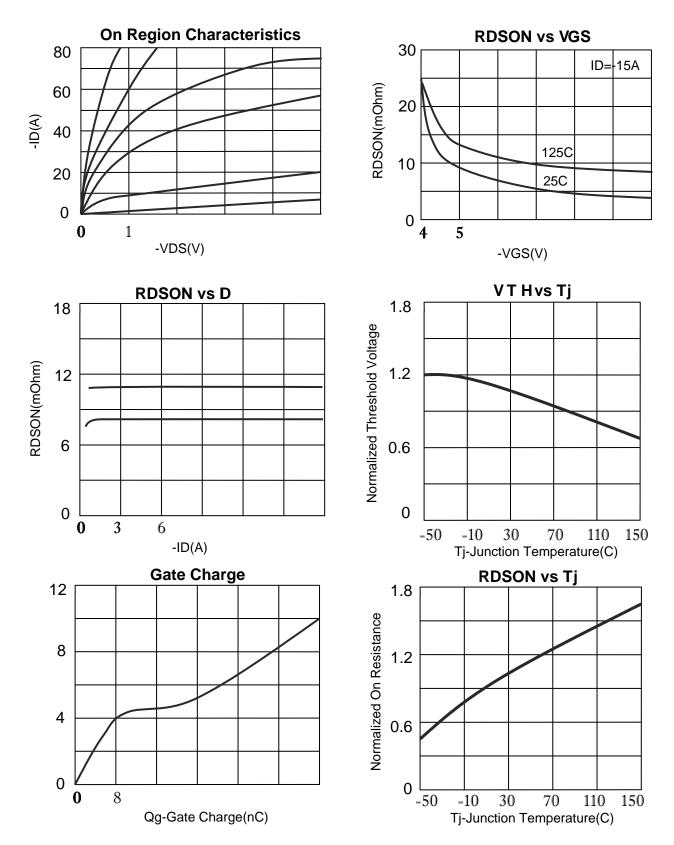
6. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



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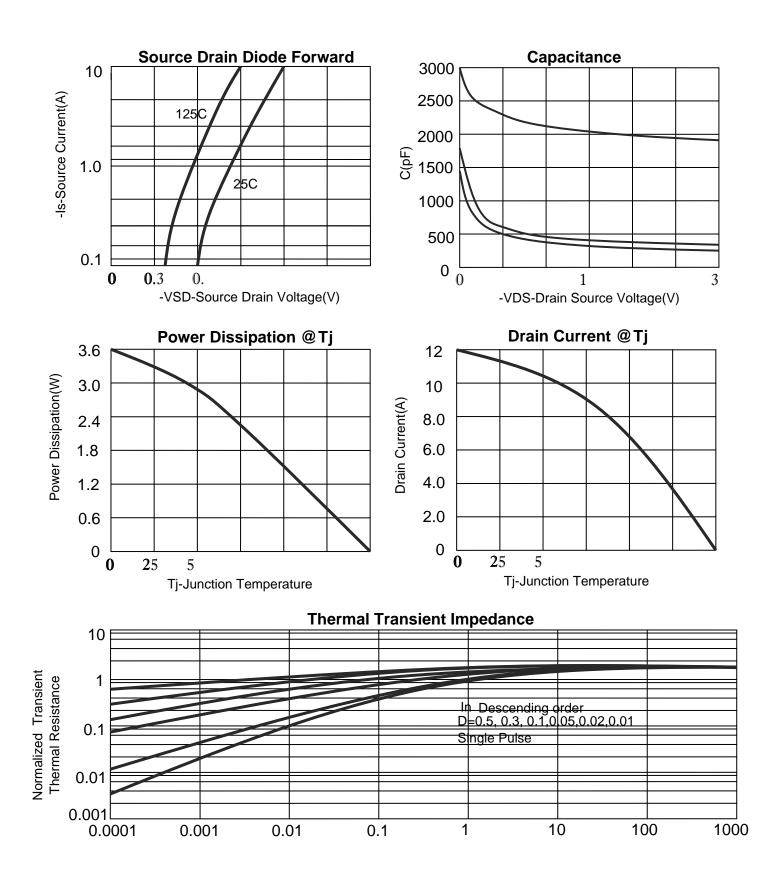
# **Typical Characteristics**





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